PTO/SB/08B (08-03) Approved for use through 07/31/2006, OMB 0651-0031 U.S. Patent and Tredemark Office; U.S. DEPARTMENT OF COMMERCE on Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number. Complete if Known **Application Number** 10/804,430 INFORMATION DISCLOSURE Filing Date 03/19/2004 STATEMENT BY APPLICANT First Named Inventor KIM ET AL. Art Unit 1765 (Use as many sheets as necessary) **Examiner Name** NORTON, NADINE G. Sheet **Attorney Docket Number** LMRX-P032 / P1205

Examiner	Cite	NON PATENT LITERATURE DOCUMENTS	
Initials*	No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T
LV	1	LEI et al., "The Effect of Ash Processes on Inorganic Porous Low-k Materials," Honeywell Electronic Materials, 4 pp.	
LV	2	COLLINS et al., "Chapter 1: Plasmas for Fun and Profit: A Survey of an Enabling Technology," 1999, pp. 1-24.	
LV	3	COLLINS et al., "Chapter 3: The Wax and Wane of Plasma Technology in IC Manufacturing," 1999, pp. 1-30.	
LV	4	GUERRA et al., "Implementation of Plasma Processing into BEOL with Organic Low-k Dielectrics," 2002 Semiconductor Equipment and Materials International, 5 pp.	

	<u> </u>		
Examiner Signature		Date /	3/2/06

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37 CFR 1.98. The Information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

## **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

## Electronic Version v18

Stylesheet Version v18.0

Title of Invention

Methods for the optimization of substrate etching in a plasma. processing system

**Application Number:** 

10/804430

7228

Confirmation Number:

First Named Applicant:

Jisoo Kim

Attorney Docket Number:

LMRX-P032/P1205

Art Unit:

1765

Examiner:

Nadine G Norton

Search string:

(6518174).pn

## **US Patent Documents**

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init (	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
W	1	6518174	2003-02-11	Annapragada, et al.			

## **Signature**

Examiner Name	Date
LAN VINI	3/2/06